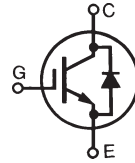


# XPT™ 600V IGBT GenX3™ w/ Diode

(Electrically Isolated Tab)

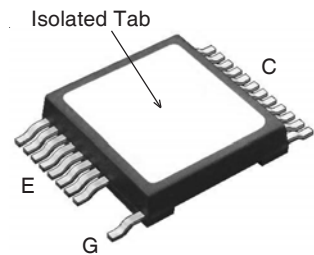
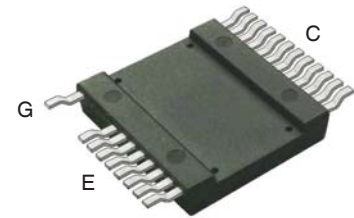
# MMIX1X100N60B3H1

$V_{CES} = 600V$   
 $I_{C110} = 68A$   
 $V_{CE(sat)} \leq 1.80V$



Extreme Light Punch Through  
IGBT for 10-30kHz Switching

| Symbol         | Test Conditions   | Maximum Ratings       |            |
|----------------|---|-----------------------|------------|
| $V_{CES}$      | $T_J = 25^\circ C$ to $150^\circ C$                       | 600                   | V          |
| $V_{CGR}$      | $T_J = 25^\circ C$ to $150^\circ C$ , $R_{GE} = 1M\Omega$ | 600                   | V          |
| $V_{GES}$      | Continuous  | $\pm 20$              | V          |
| $V_{GEM}$      | Transient   | $\pm 30$              | V          |
| $I_{C25}$      | $T_C = 25^\circ C$ (Chip Capability)                      | 145                   | A          |
| $I_{C110}$     | $T_C = 110^\circ C$                                       | 68                    | A          |
| $I_{F90}$      | $T_C = 90^\circ C$  | 54                    | A          |
| $I_{CM}$       | $T_C = 25^\circ C$ , 1ms                                  | 440                   | A          |
| $I_A$          | $T_C = 25^\circ C$  | 50                    | A          |
| $E_{AS}$       | $T_C = 25^\circ C$  | 600                   | mJ         |
| <b>SSOA</b>    | $V_{GE} = 15V$ , $T_{VJ} = 150^\circ C$ , $R_G = 2\Omega$ | $I_{CM} = 200$        | A          |
| <b>(RBSOA)</b> | Clamped Inductive Load                                    | $V_{CE} \leq V_{CES}$ |            |
| $t_{sc}$       | $V_{GE} = 15V$ , $V_{CE} = 360V$ , $T_J = 150^\circ C$    | 10                    | $\mu s$    |
| <b>(SCSOA)</b> | $R_G = 10\Omega$ , Non Repetitive                         |                       |            |
| $P_C$          | $T_C = 25^\circ C$  | 400                   | W          |
| $T_J$          |   | -55 ... +150          | $^\circ C$ |
| $T_{JM}$       |   | 150                   | $^\circ C$ |
| $T_{stg}$      |   | -55 ... +150          | $^\circ C$ |
| $T_L$          | Maximum Lead Temperature for Soldering                    | 300                   | $^\circ C$ |
| $T_{SOLD}$     | 1.6 mm (0.062 in.) from Case for 10s                      | 260                   | $^\circ C$ |
| $V_{ISOL}$     | 50/60Hz, 1 minute   | 2500                  | V~         |
| $F_C$          | Mounting Force  | 50..200/11..45        | N/lb.      |
| <b>Weight</b>  |   | 8                     | g          |



G = Gate                      E = Emitter  
 C = Collector

### Features

- Silicon Chip on Direct-Copper Bond (DCB) Substrate
- Isolated Mounting Surface
- 2500V~ Electrical Isolation
- Optimized for 10-30kHz Switching
- Square RBSOA
- FBSOA
- Avalanche Rated
- Short Circuit Capability
- Anti-Parallel Ultra Fast Diode
- High Current Handling Capability

### Advantages

- High Power Density
- Low Gate Drive Requirement

### Applications

- Power Inverters
- UPS
- Motor Drives
- SMPS
- PFC Circuits
- Battery Chargers
- Welding Machines
- Lamp Ballasts

| Symbol        | Test Conditions<br>( $T_J = 25^\circ C$ , Unless Otherwise Specified) | Characteristic Values |              |                    |
|---------------|---|-----------------------|--------------|--------------------|
|               |   | Min.                  | Typ.         | Max.               |
| $BV_{CES}$    | $I_C = 250\mu A$ , $V_{GE} = 0V$                                      | 600                   |              | V                  |
| $V_{GE(th)}$  | $I_C = 250\mu A$ , $V_{CE} = V_{GE}$                                  | 3.0                   |              | 5.5 V              |
| $I_{CES}$     | $V_{CE} = V_{CES}$ , $V_{GE} = 0V$<br>$T_J = 125^\circ C$             |                       |              | 50 $\mu A$<br>4 mA |
| $I_{GES}$     | $V_{CE} = 0V$ , $V_{GE} = \pm 20V$                                    |                       |              | $\pm 100$ nA       |
| $V_{CE(sat)}$ | $I_C = 70A$ , $V_{GE} = 15V$ , Note 1<br>$T_J = 150^\circ C$          |                       | 1.50<br>1.77 | V<br>V             |

| Symbol Test Conditions<br>( $T_J = 25^\circ\text{C}$ Unless Otherwise Specified) |   | Characteristic Values |      |                    |
|--|---|-----------------------|------|--------------------|
|  |   | Min.                  | Typ. | Max.               |
| $g_{fs}$   | $I_C = 60\text{A}, V_{CE} = 10\text{V}, \text{Note 1}$  | 22                    | 40   | S                  |
| $C_{ies}$  | $V_{CE} = 25\text{V}, V_{GE} = 0\text{V}, f = 1\text{MHz}$  |                       | 4860 | pF                 |
| $C_{oes}$  |   |                       | 475  | pF                 |
| $C_{res}$  |   |                       | 83   | pF                 |
| $Q_{g(on)}$  | $I_C = 70\text{A}, V_{GE} = 15\text{V}, V_{CE} = 0.5 \cdot V_{CES}$   |                       | 143  | nC                 |
| $Q_{ge}$   |   |                       | 37   | nC                 |
| $Q_{gc}$   |   |                       | 60   | nC                 |
| $t_{d(on)}$  | <b>Inductive load, <math>T_J = 25^\circ\text{C}</math></b><br>$I_C = 70\text{A}, V_{GE} = 15\text{V}$<br>$V_{CE} = 360\text{V}, R_G = 2\Omega$<br>Note 2  |                       | 30   | ns                 |
| $t_{ri}$   |   |                       | 70   | ns                 |
| $E_{on}$   |   |                       | 1.9  | mJ                 |
| $t_{d(off)}$   |   |                       | 120  | ns                 |
| $t_{fi}$   |   |                       | 150  | ns                 |
| $E_{off}$  |   |                       | 2.0  | 2.8 mJ             |
| $t_{d(on)}$  | <b>Inductive load, <math>T_J = 150^\circ\text{C}</math></b><br>$I_C = 70\text{A}, V_{GE} = 15\text{V}$<br>$V_{CE} = 360\text{V}, R_G = 2\Omega$<br>Note 2 |                       | 32   | ns                 |
| $t_{ri}$   |   |                       | 60   | ns                 |
| $E_{on}$   |   |                       | 2.3  | mJ                 |
| $t_{d(off)}$   |   |                       | 150  | ns                 |
| $t_{fi}$   |   |                       | 200  | ns                 |
| $E_{off}$  |   |                       | 2.8  | mJ                 |
| $R_{thJC}$   |   |                       | 0.31 | $^\circ\text{C/W}$ |
| $R_{thCS}$   |   | 0.05                  |      | $^\circ\text{C/W}$ |

**Reverse Diode (FRED)**

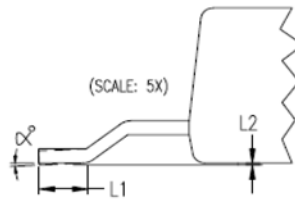
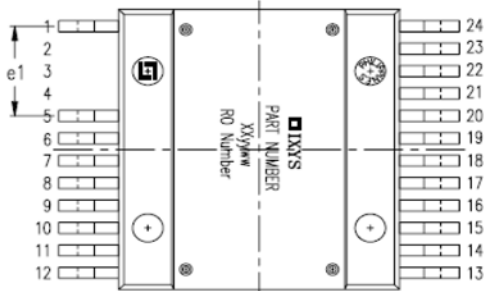
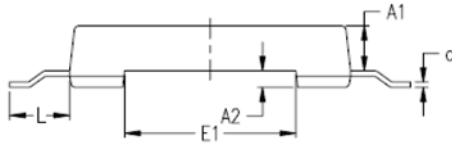
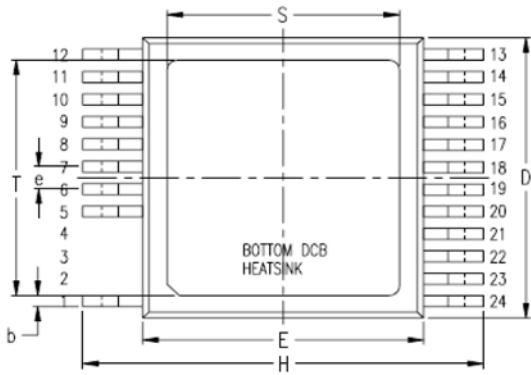
| Symbol Test Conditions<br>( $T_J = 25^\circ\text{C}$ Unless Otherwise Specified) |   | Characteristic Values |      |                    |
|--|---|-----------------------|------|--------------------|
|  |   | Min.                  | Typ. | Max.               |
| $V_F$  | $I_F = 60\text{A}, V_{GE} = 0\text{V}, \text{Note 1}$<br>$T_J = 150^\circ\text{C}$  |                       | 1.6  | 2.5 V              |
|  |   |                       | 1.4  | 1.8 V              |
| $I_{RM}$   | $I_F = 60\text{A}, V_{GE} = 0\text{V},$<br>$-di_F/dt = 200\text{A}/\mu\text{s}, V_R = 300\text{V}$<br>$T_J = 100^\circ\text{C}$ |                       | 8.3  | A                  |
| $t_{rr}$   |   |                       | 140  | ns                 |
| $R_{thJC}$   |   |                       | 0.62 | $^\circ\text{C/W}$ |

**Notes:**

1. Pulse test,  $t \leq 300\mu\text{s}$ , duty cycle,  $d \leq 2\%$ .
2. Switching times & energy losses may increase for higher  $V_{CE}(\text{clamp})$ ,  $T_J$  or  $R_G$ .

IXYS Reserves the Right to Change Limits, Test Conditions, and Dimensions.

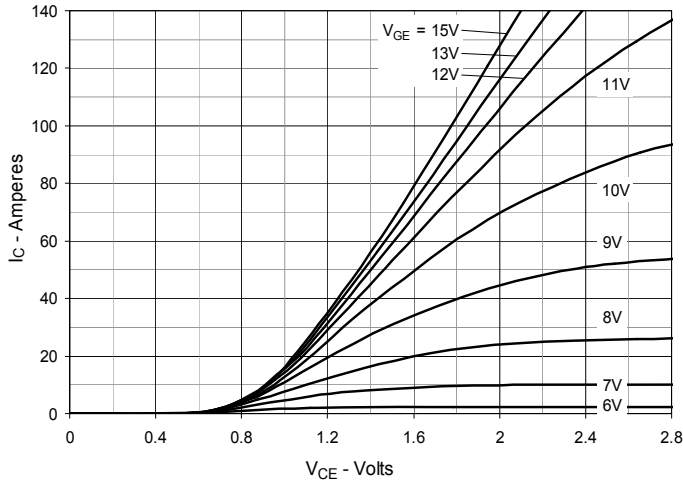
## Package Outline



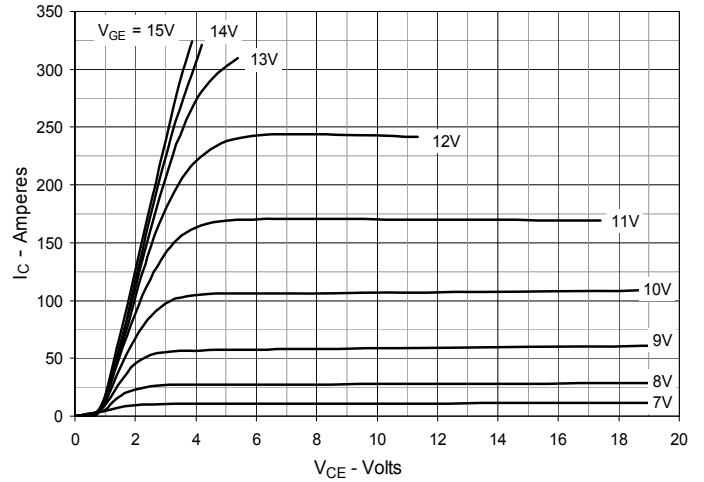
| SYM | INCHES   |       | MILLIMETERS |       |
|-----|----------|-------|-------------|-------|
|     | MIN      | MAX   | MIN         | MAX   |
| A   | .209     | .224  | 5.30        | 5.70  |
| A1  | .154     | .161  | 3.90        | 4.10  |
| A2  | .055     | .063  | 1.40        | 1.60  |
| b   | .035     | .045  | 0.90        | 1.15  |
| c   | .018     | .026  | 0.45        | 0.65  |
| D   | .976     | .994  | 24.80       | 25.25 |
| E   | .898     | .915  | 22.80       | 23.25 |
| E1  | .543     | .559  | 13.80       | 14.20 |
| e   | .079 BSC |       | 2.00 BSC    |       |
| e1  | .315 BSC |       | 8.00 BSC    |       |
| H   | 1.272    | 1.311 | 32.30       | 33.30 |
| L   | .181     | .209  | 4.60        | 5.30  |
| L1  | .051     | .067  | 1.30        | 1.70  |
| L2  | .000     | .006  | 0.00        | 0.15  |
| S   | .736     | .760  | 18.70       | 19.30 |
| T   | .815     | .839  | 20.70       | 21.30 |
| ∞   | 0        | 4*    | 0           | 4*    |

**PIN: 1 = Gate**  
**5-12 = Emitter**  
**13-24 = Collector**

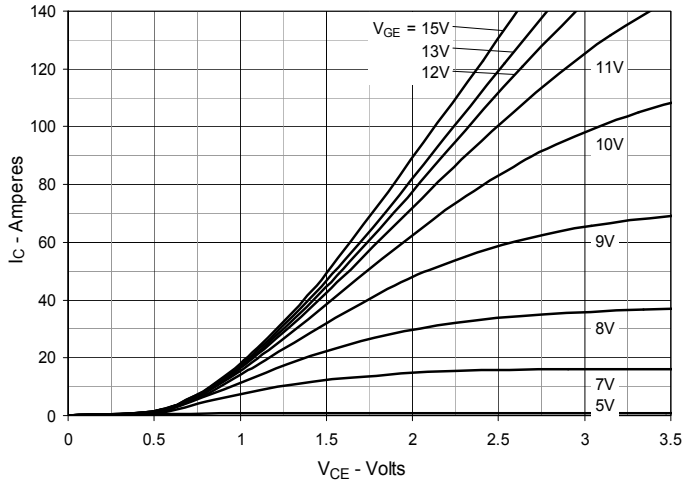
**Fig. 1. Output Characteristics @  $T_J = 25^\circ\text{C}$**



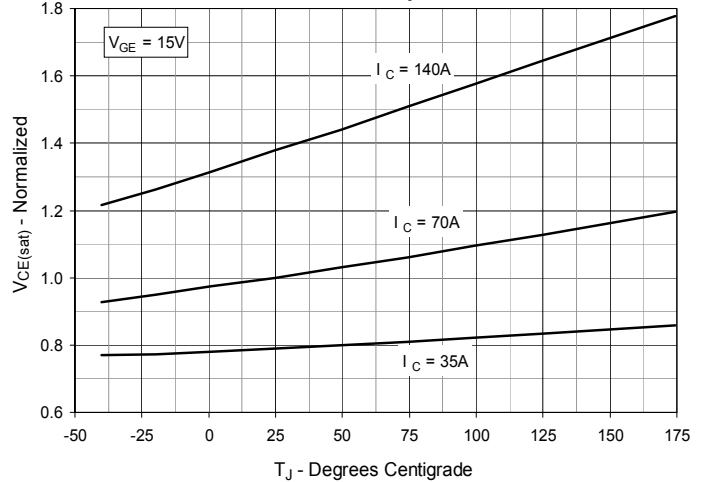
**Fig. 2. Extended Output Characteristics @  $T_J = 25^\circ\text{C}$**



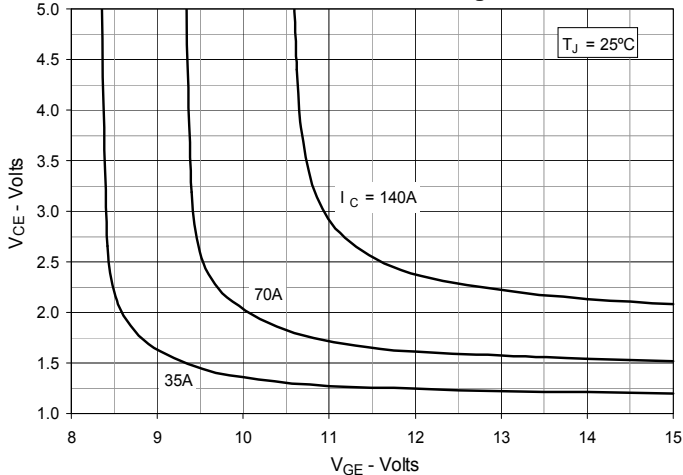
**Fig. 3. Output Characteristics @  $T_J = 150^\circ\text{C}$**



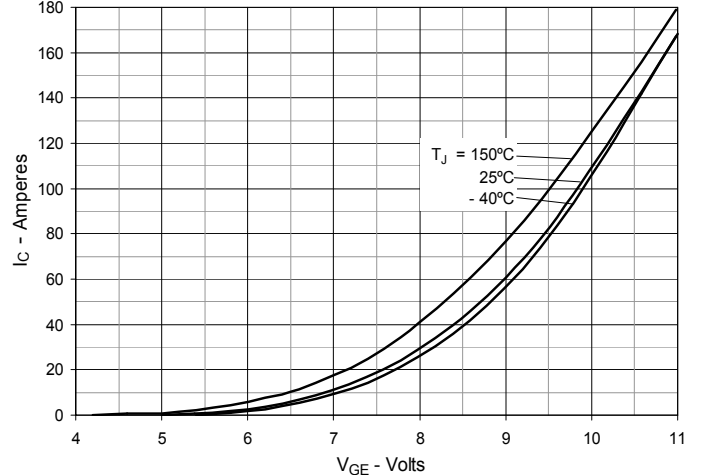
**Fig. 4. Dependence of  $V_{CE(sat)}$  on Junction Temperature**



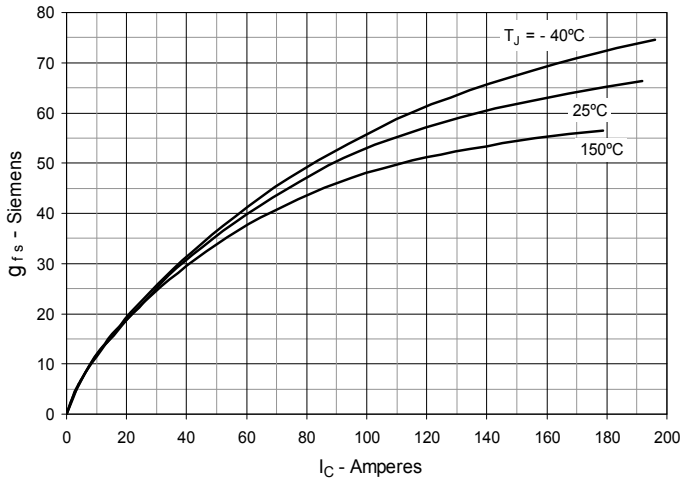
**Fig. 5. Collector-to-Emitter Voltage vs. Gate-to-Emitter Voltage**



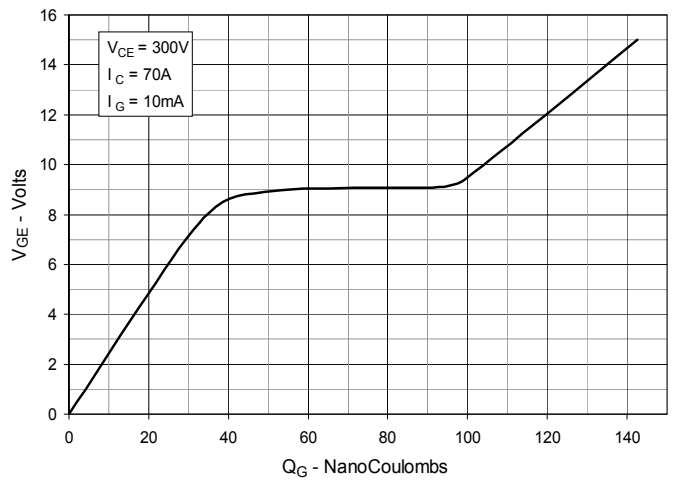
**Fig. 6. Input Admittance**



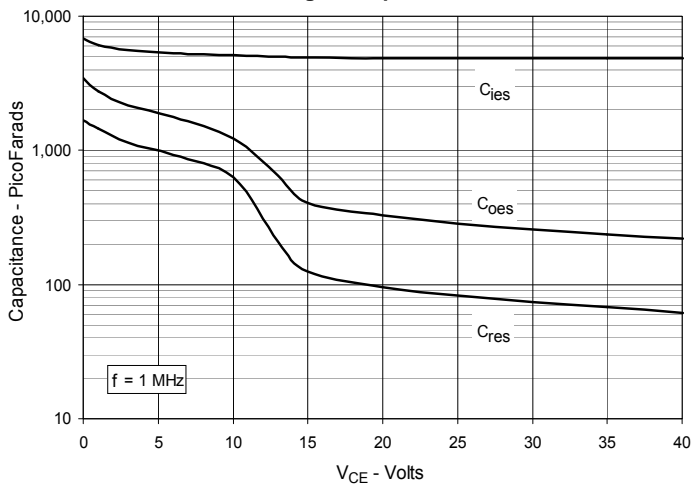
**Fig. 7. Transconductance**



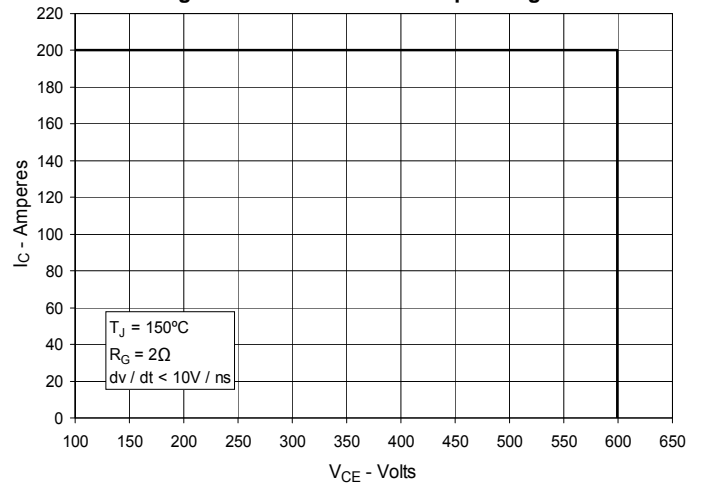
**Fig. 8. Gate Charge**



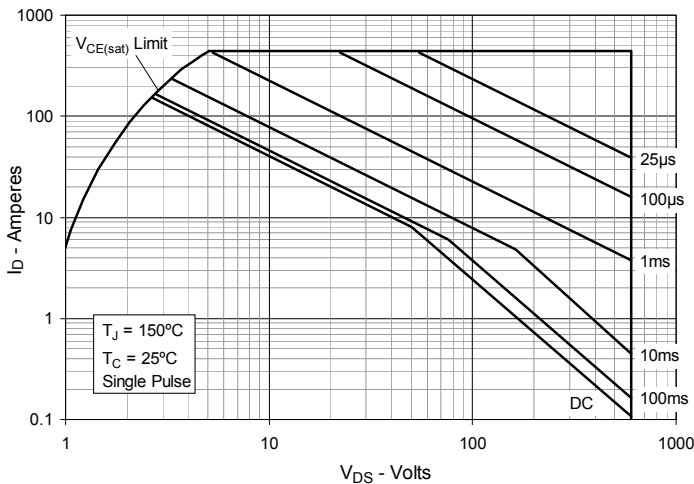
**Fig. 9. Capacitance**



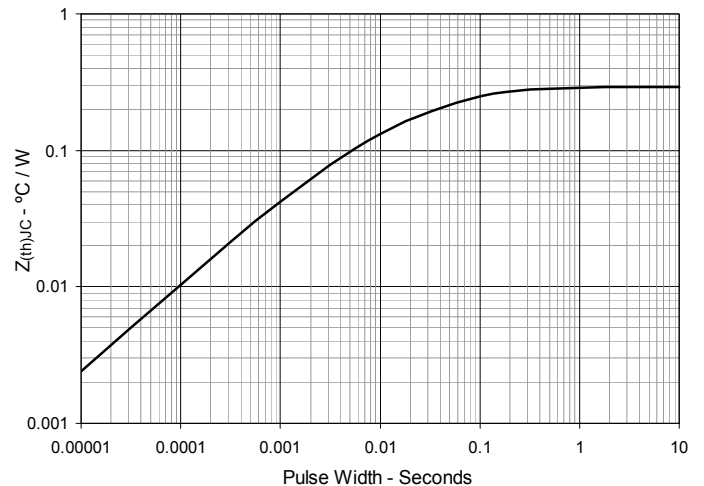
**Fig. 10. Reverse-Bias Safe Operating Area**



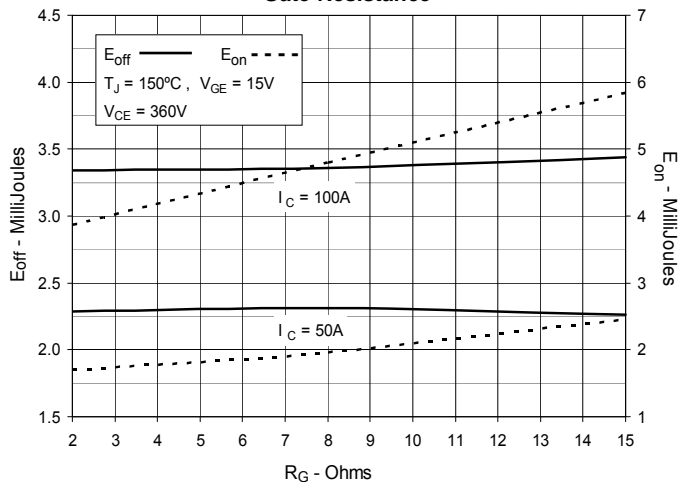
**Fig. 11. Forward-Bias Safe Operating Area**



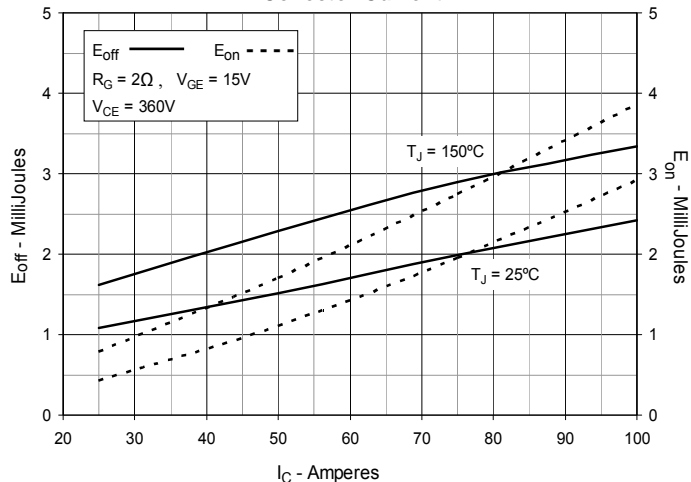
**Fig. 12. Maximum Transient Thermal Impedance**



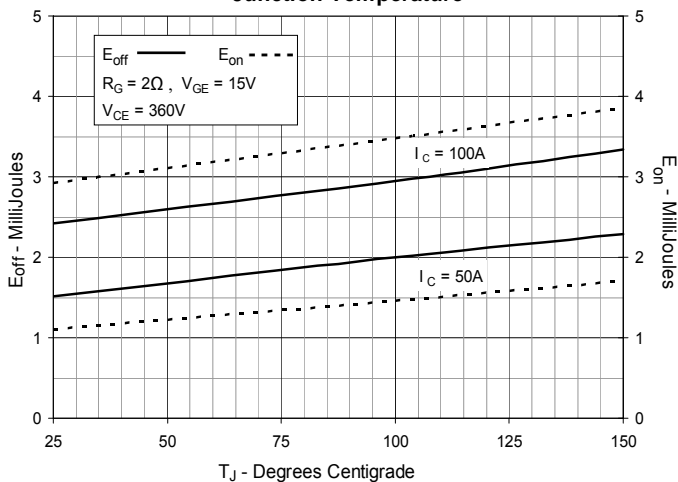
**Fig. 13. Inductive Switching Energy Loss vs. Gate Resistance**



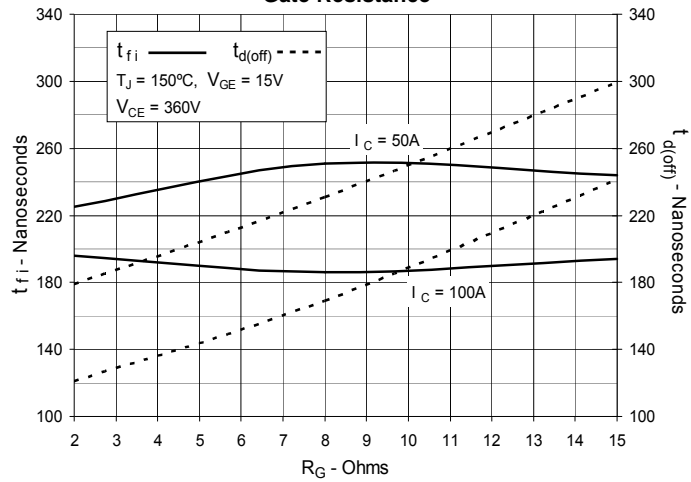
**Fig. 14. Inductive Switching Energy Loss vs. Collector Current**



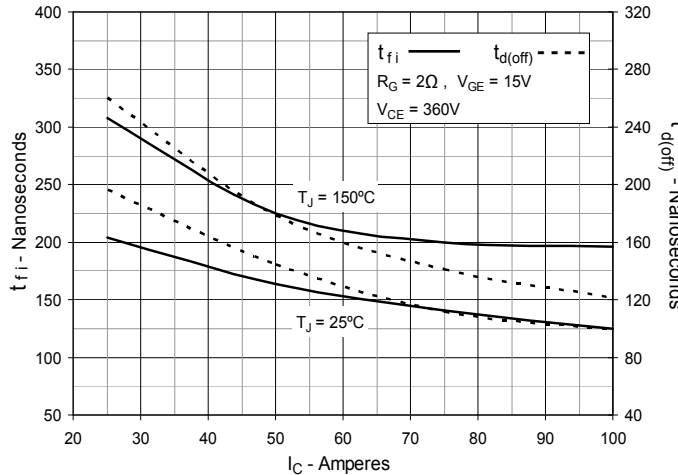
**Fig. 15. Inductive Switching Energy Loss vs. Junction Temperature**



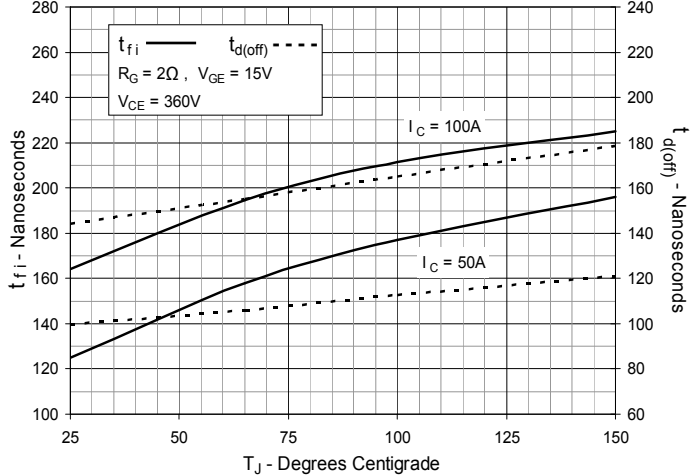
**Fig. 16. Inductive Turn-off Switching Times vs. Gate Resistance**



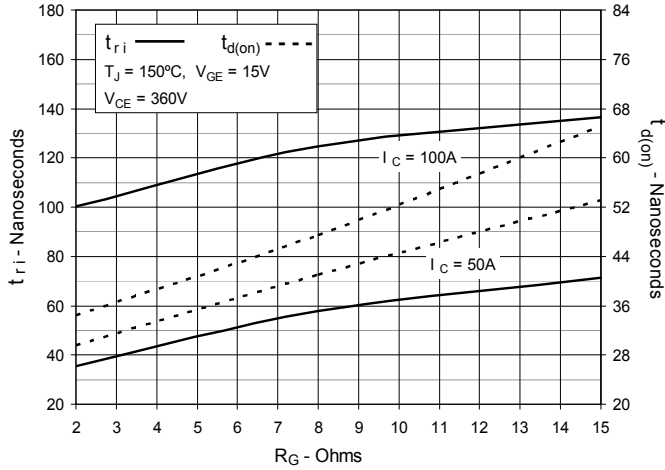
**Fig. 17. Inductive Turn-off Switching Times vs. Collector Current**



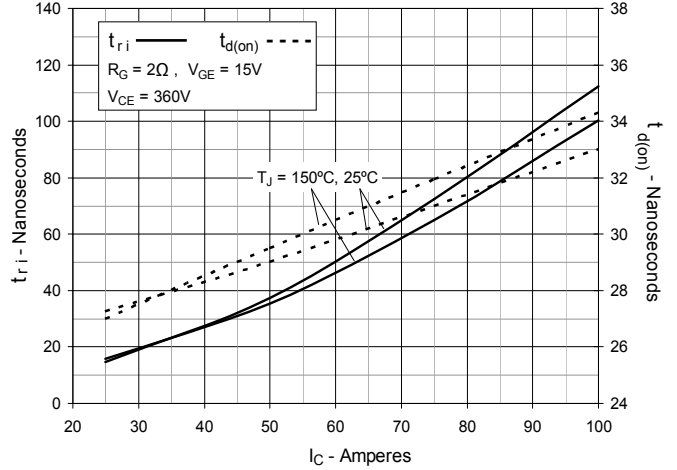
**Fig. 18. Inductive Turn-off Switching Times vs. Junction Temperature**



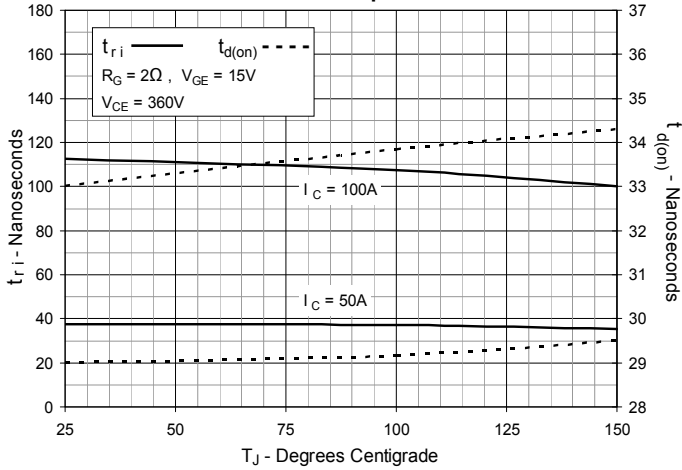
**Fig. 19. Inductive Turn-on Switching Times vs. Gate Resistance**

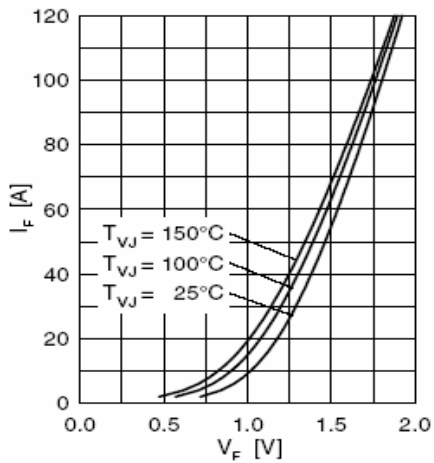


**Fig. 20. Inductive Turn-on Switching Times vs. Collector Current**

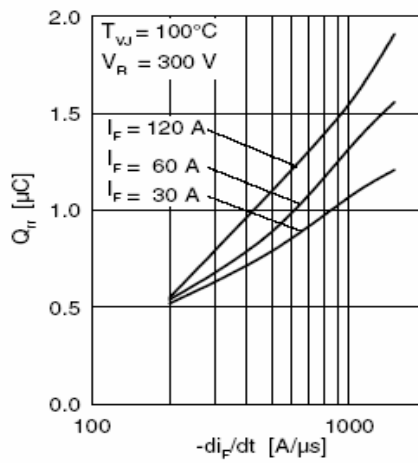


**Fig. 21. Inductive Turn-on Switching Times vs. Junction Temperature**

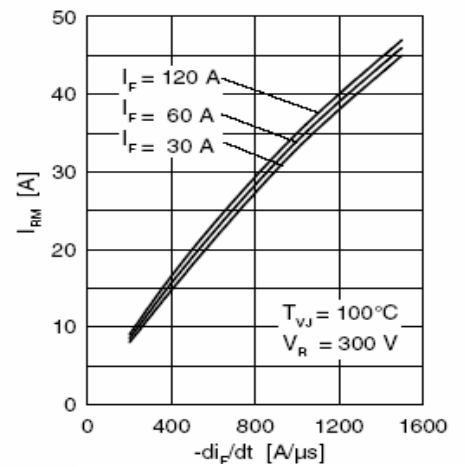




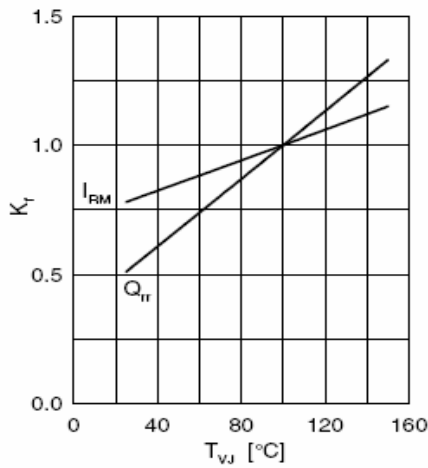
**Fig. 22 Forward Current  $I_F$  vs.  $V_F$**



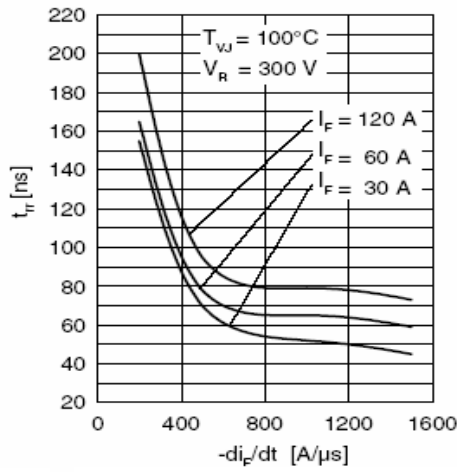
**Fig. 23 Typ. Reverse Recovery Charge  $Q_{rr}$**



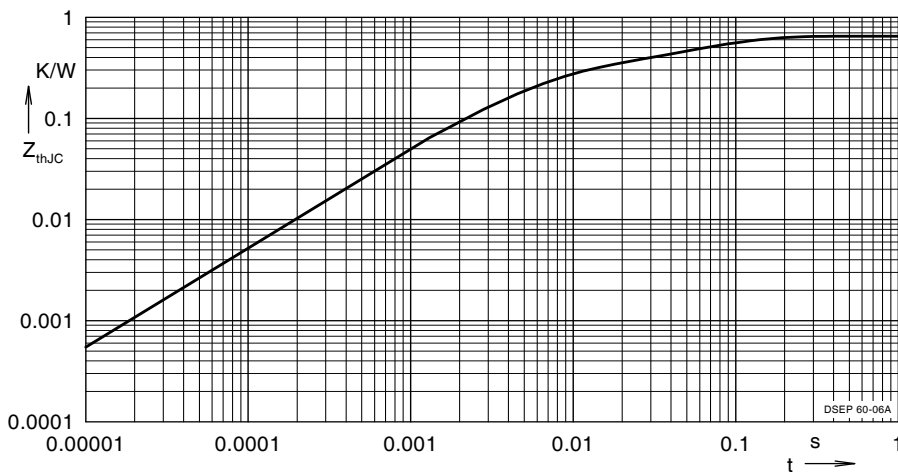
**Fig. 24 Typ. Peak Reverse Current  $I_{RM}$**



**Fig. 25 Typ. Dynamic Parameters  $Q_{rr}$ ,  $I_{RM}$**



**Fig. 26 Typ. Recovery Time  $t_{rr}$**



**Fig. 27. Maximum Transient Thermal Impedance**





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